

Using Cutting-Edge Tools to Test Firmware for Uninterruptible Power Supplies

HIL & Real time Power Electronics Simulation



Jean-Louis Schricke - MESULOG



SOCOMEC Activities

Critical Power

Ensuring the availability of high-quality power for critical applications

Energy Efficiency

Improving the energy performance of buildings and installations

Power Control & Safety

Managing power and protecting people, equipment and installations

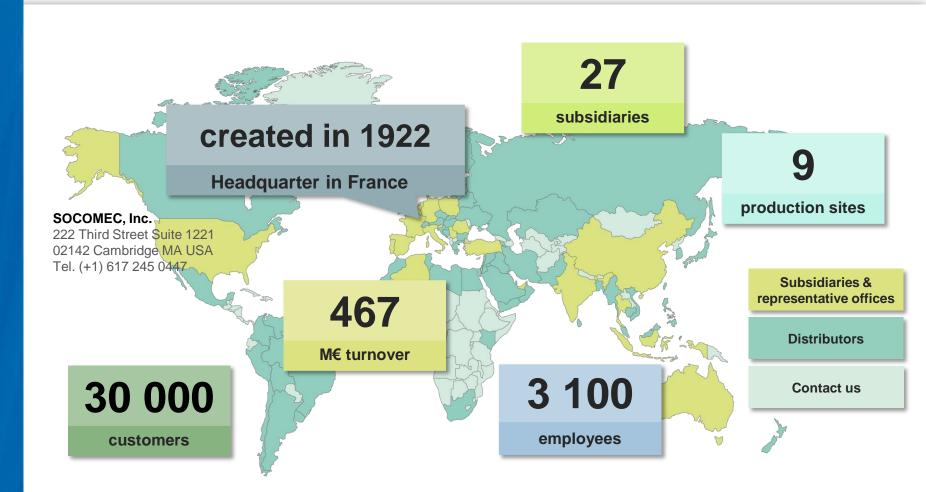


Enabling available, safe and efficient energy





SOCOMEC Figures







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Critical Power Specialist positioning





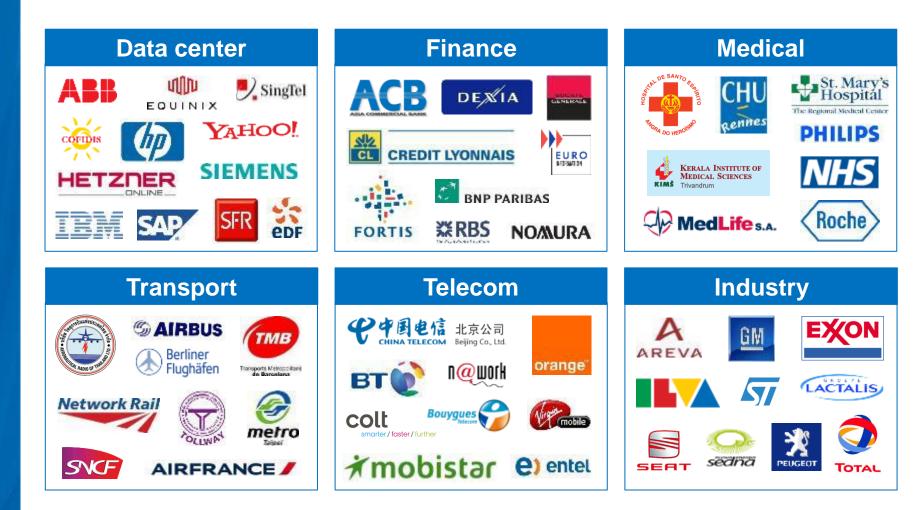




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Critical Power Customer confidence



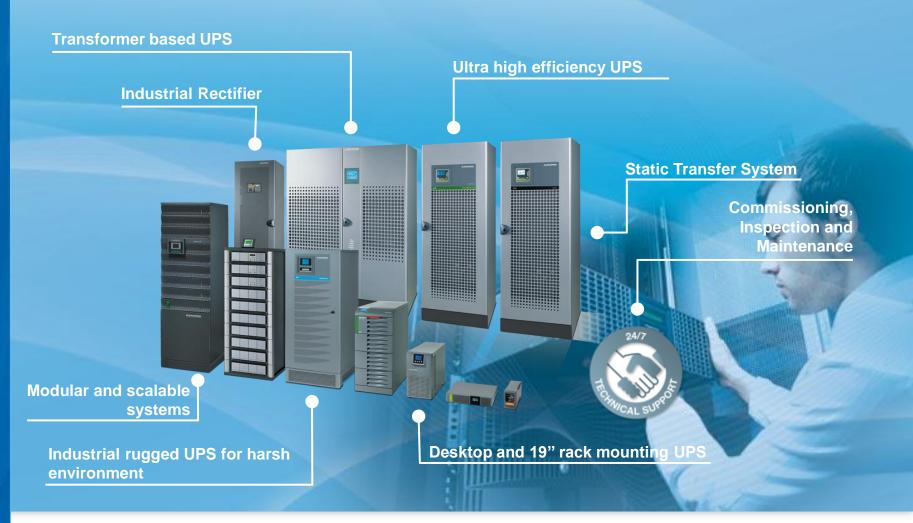






Critical Power A wide range of solutions...









Critical Power Continuous innovation





1968 1st UPS

1987 1st Static Transfer System (STS)

1988 Transistor technology (600 kVA)

1989 IGBT & microprocessor **1990** Distributed parallel architecture

1994 Transformerless technology

1996 IGBT up to 800 kVA

1998 Digital Signal Processor (DSP) **2001** 1st modular UPS

2003 IGBT rectifiers up to 200 kVA

2004 Expert Battery System (EBS)

2006 Flywheel UPS

2008 High efficiency UPS **2010** Green Power

2012 High power 3L technology

2014 "Forever Young" design for modular UPS

2015

Rack-mounted modular UPS

Innovative Battery reinjection test

Real hot-scalable UPS system up to 1.2 MW





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- 2016: why an HIL simulator ?
 - Shorten the development time
 - Test new added functionalities
 - Do not blow costly (and rare) prototypes
 - Reproduce harsh environment variables (grid dips, voltage distortion, frequency variations, etc.)
 - Realize full featured non regression test

→ Continue improving product quality





Critical Power Continuous improvement



- Development process :
 - Specification reviews
 - Design reviews
 - Coding reviews
 - Unit test

• Product qualification

- done by experts on specific items
- Field
- Problems seen on the field (environment)



Many feedbacks





Few feedbacks

Critical Power Continuous improvement



- Development process :
 - Specification reviews
 - Design reviews
 - Coding reviews
 - Unit test
 - Testing modifications with HIL
 - Regression test done with HIL
 - Robustness test done with HIL (voltage / frequency limits / sensor failures, etc.)
 - Product qualification
 - done by experts on specific items
- Field
- Reproduce problems seen on the field (waveforms, environment)



Many feedbacks



August 2016

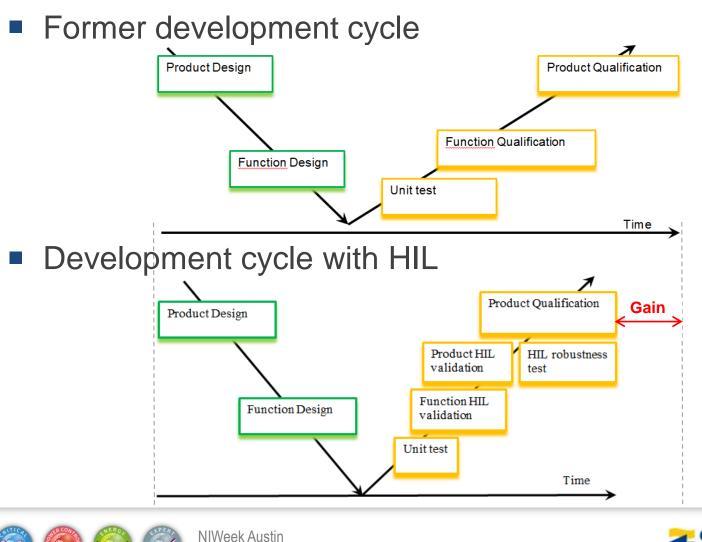




Critical Power Continuous improvement

August 2016









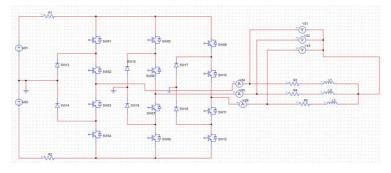
- Physical characteristics
 - Switching frequency above 10 kHz
 - All signals of a unit shall be simulated
 - Accurate simulated signals in order to use standard firmware
- For a unit : 150 environment variables
 - More than 50 electronic components (diodes, IGBTs, SCRs)
 - Real time constraints above 100 kHz (10 µs)
 - More than 30 analog signals
 - More than 40 PWM signals
 - Real time constraints about 1 kHz (1 ms)
 - Temperature sensors
 - Auxiliary switches
 - Digital outputs







- User-friendly HIL simulation
 - No specific modelling knowledge
 - Change the simulated device in a short time
 - Use standard device schematics like PSIM
 - Avoid any FPGA compilation

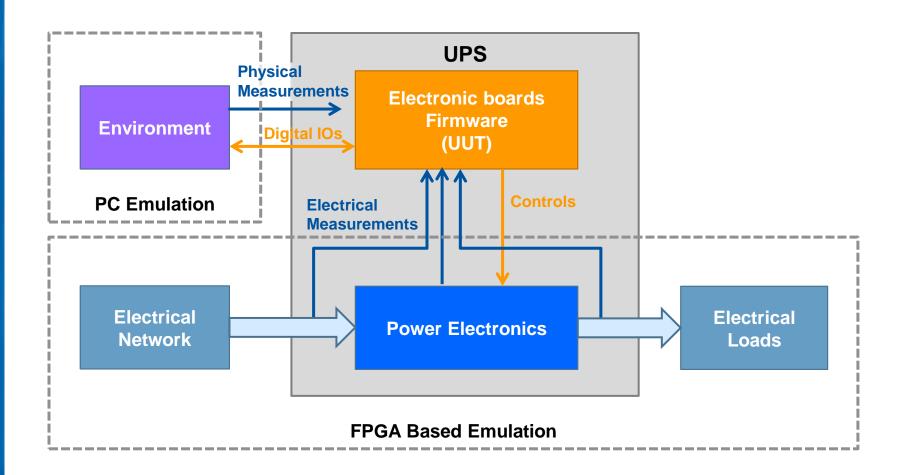


- Use standard test tools
 - Integrated solution
 - One hardware platform for all functionalities
 - One supplier for test software















- What has to be simulated ?
 - Power electronics (IGBTs, SCRs)
 - 3 level power bridges from 3 to 300 kW
 - Power components
 - resistors, inductors, capacitors, transformer
 - DC energy storage
 - Batteries (lead acid, nickel cadmium, lithium-ion)
 - Lithium-ion capacitors
 - Load
 - Motors
 - Non-linear loads
 - AC generators
 - Grid or gensets (voltage and frequency variation)

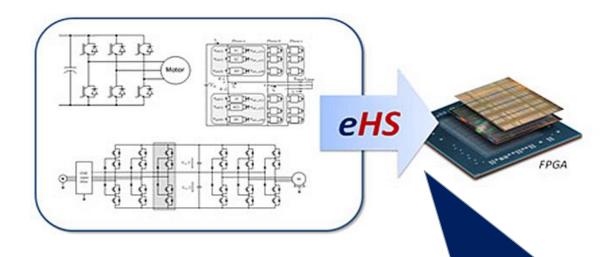








eHS is a revolutionary floating-point solver for *physical real-time simulation of an electric circuit on FPGA.*



No Mathematical Modeling No FPGA expertise No VHDL programming









Opal-RT eHSx64 solver

	eHSx64	
Inputs	48	
Outputs	32	
Switches	> 64	
L-C	150	
R	Unlimited	
NPC time step	~ 200ns	

- < 1 µs computing cycle
- Overall delay (PWM input to analog output about 4 µs) thanks to the high data transfer rate of the PXIe bus





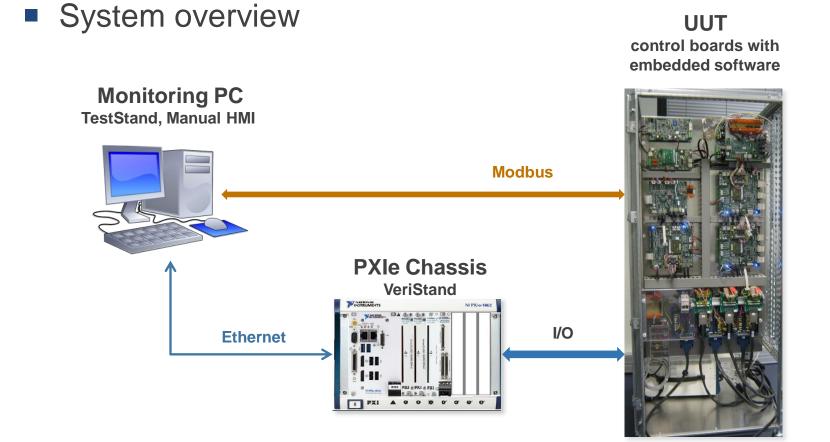


- Partnership between 2 leaders: NI and Opal-RT
- The solution:
 - Opal-RT eHSx64 solver for NI FPGA boards
 - NI VeriStand for the hardware interface and models
 - NI TestStand for the test sequence automation
 - NI LabVIEW programming language used for:
 - VeriStand Slow Models and Custom Devices
 - TestStand Custom Steps and Operator Interface





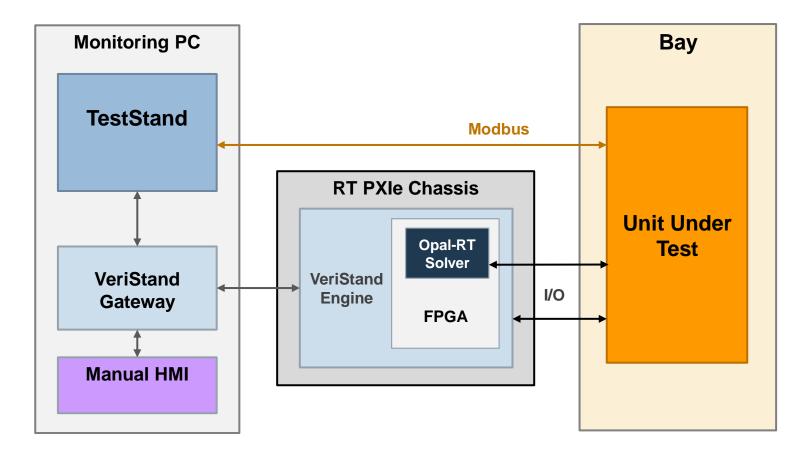












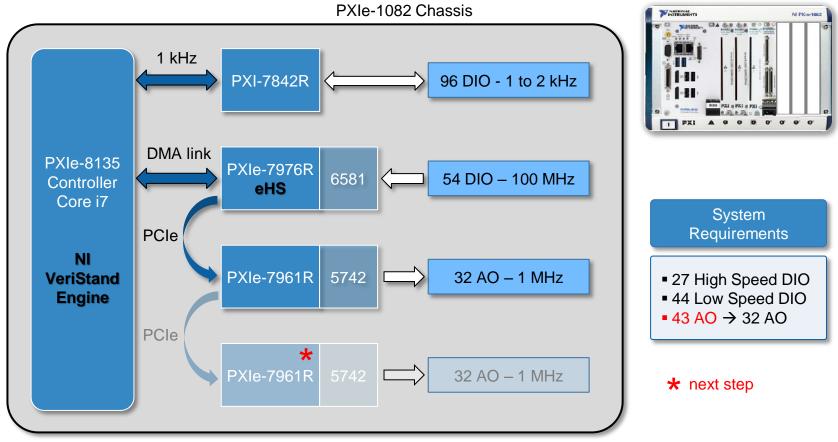








Hardware solution:

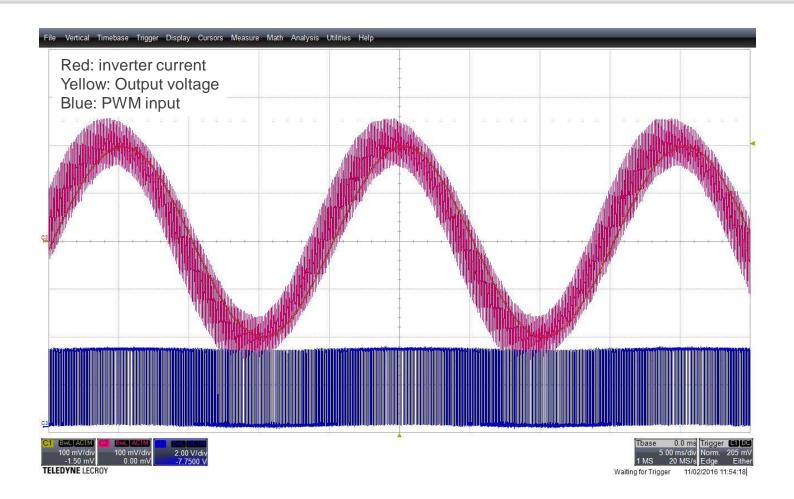






Critical Power HIL simulation results



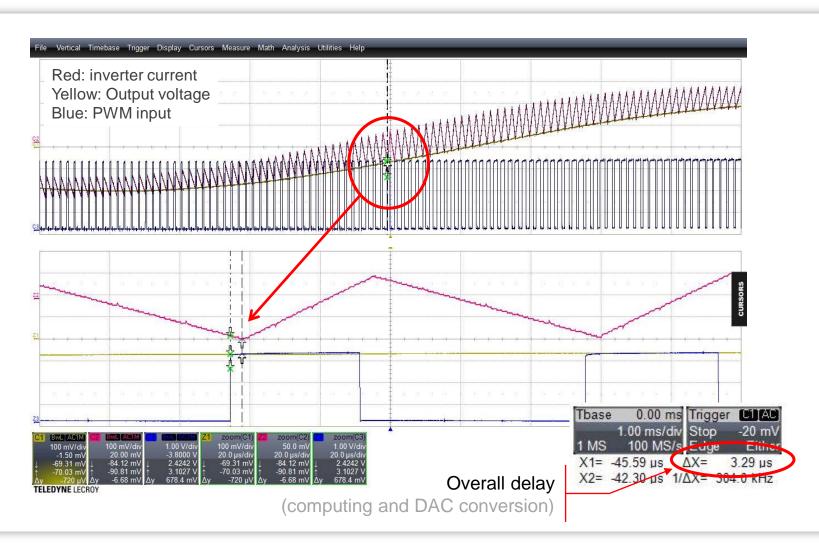






Critical Power HIL simulation results













- Collaboration with MESULOG, NI partner
 - Software architecture
 - Manual HMI (Monkey Test)
 - TestStand Step Types and Operator Interface
 - Software development support and assistance









- Manual HMI (Monkey test)
 - User-friendly interface for operators
 - Developed with LabVIEW and VeriStand API
 - VeriStand Workspace not used by operators
 - Will be integrated later into TS Operator Interface

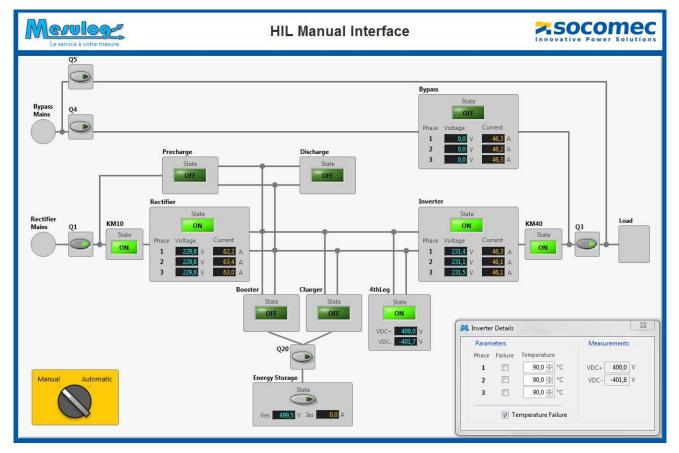








Manual HMI (Monkey test)









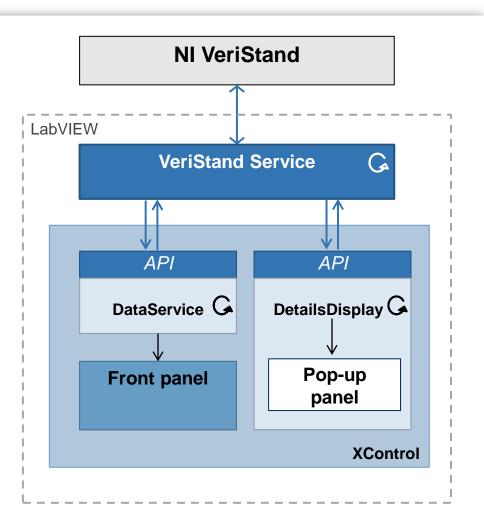
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- Manual HMI
 - Innovative solution
 - Modular and generic
 - Power brick classes
- 11 XControls
 - One per class
 - 18 instances
 - Linked to VeriStand alias sub-folder
 - Continuous value update
 - Additional pop-up panels

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TestStand Custom Step Types : PROTOCOL

- Abstraction layer to access
 UUT internal data via Modbus
- Based on a XML file, that describes product data structure
- Configuration with a tree browser
- Search tool
- Based on TestStand add-on



www.mesulog.fr/modbussteps

Item	Description	
E C Product	Description	<u> </u>
GOMBoard		
🗏 🏬 Comboard		
Areasurements		
123 AMInvVmM000	Output Load Rate	
123 AMInvVmM001	Output Load Rate L1	
123 AMInvVmM002	Output Load Rate L2	
123 AMInvVmM003	Output Load Rate L3	
123 AMInvVmM004	Output Apparent Power	
123 AMInvVmM005	Output Active Power	
123 AMInvVmM006	Output current L1	
123 AMIn√VmM007	Output current L2	
123 AMInvVmM008	Output current L3	
123 AMInvVmM009	Output Neutral current	
123 AMInvVmM010	Output voltage L1	
123 AMInvVmM011	Output voltage L2	
123 AMInvVmM012	Output voltage L3	-
D M MT or M (mon M 012	Output frequency	
Acronym: AMInvVmM001		



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- TestStand Custom Step Types : VeriStand
 - Modular and reusable steps to interact with VeriStand



- TestStand Custom Step Types : UTILITIES
 - Specific SequenceCall with retry strategy on expected errors

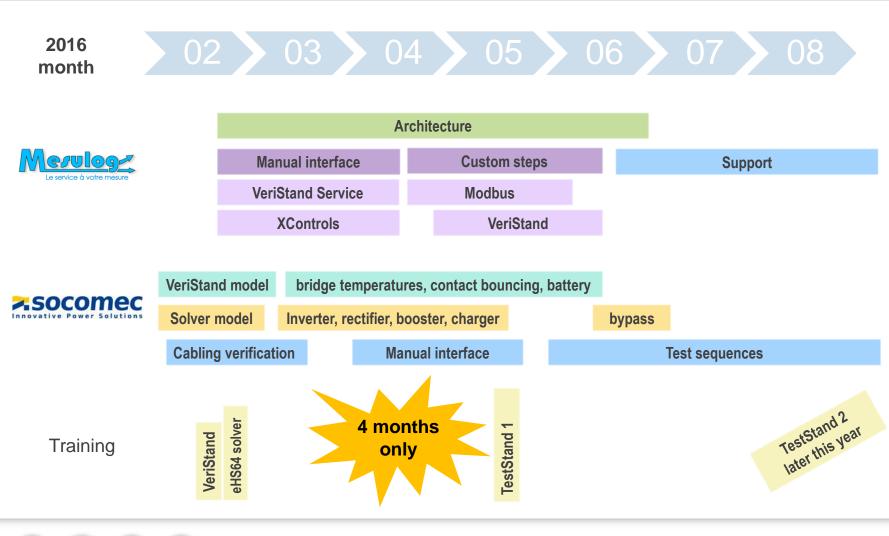




Critical Power HIL schedule









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Critical Power HIL results



- Feedbacks
 - What doesn't work on the HIL, will not work on the prototype
 - Once a problem detected, it is easy to reproduce and replay
 - A problem is solved in a shorter time (about a third / physical prototype)
- Main firmware problems already detected
 - Specification interpretation
 - Timing
 - Signal filtering
 - Closed loop control stability
- HIL few human bugs ⁽²⁾
 - Physical cabling (wrong input/output, signal inversion)
 - LabVIEW models development
 - Wrong sensor gain settings (400V signals to 0-5V signals adaptation, current sensors)
 - Test sequence timing compare to UPS internal variable settling time







- Next steps
 - Higher power systems
 - more IGBT switches to control
 - Parallel systems
 - At least 2 units in parallel with same I/O latency
 - Target : 16 units in parallel (16 x 150 IOs = 2400 IOs)
 - Opal-RT solver improvement
 - next NI FlexRIO board ?











thank you SO much!

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